

# MOSFET - Power, Single N-Channel, Source Down, WDFN9

## 40 V, 1.3 mΩ, 207 A

### NTTFSSH1D3N04XL

#### Features

- Advanced Source-Down Package Technology (3.3x3.3mm) with Excellent Thermal Conduction
- Low  $R_{DS(on)}$  to Minimize Conduction Loss
- Low QRR with Soft Recovery to Minimize ERR Loss and Voltage Spike
- Low  $Q_G$  and Capacitance to Minimize Driving and Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

#### Applications

- High Switching Frequency DC-DC Conversion
- Synchronous Rectifier

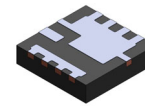
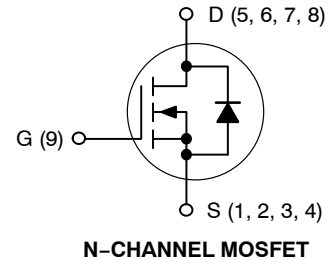
#### MAXIMUM RATINGS ( $T_J = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	$V_{DSS}$	40	V
Gate-to-Source Voltage	DC $V_{GS}$	$\pm 20$	V
Continuous Drain Current	$I_D$	$T_C = 25^\circ\text{C}$	207
		$T_C = 100^\circ\text{C}$	146
Power Dissipation	$P_D$	107	W
Pulsed Drain Current	$I_{DM}$	812	A
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	-55 to +175	$^\circ\text{C}$
Continuous Source-Drain Current (Body Diode)	$I_S$	184	A
Single Pulse Avalanche Energy ( $I_{PK} = 52\text{ A}$ )	$E_{AS}$	135	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	$T_L$	260	$^\circ\text{C}$

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are valid for the particular conditions noted.
2. Surface-mounted on FR4 board using a 1 in<sup>2</sup> pad size, 1 oz Cu pad.
3.  $E_{AS}$  of 135 mJ is based on started  $T_J = 25^\circ\text{C}$ ,  $I_{AS} = 52\text{ A}$ ,  $V_{DD} = 32\text{ V}$ ,  $V_{GS} = 10\text{ V}$ , 100% avalanche tested.

$V_{(BR)DSS}$	$R_{DS(ON)}\text{ MAX}$	$I_D\text{ MAX}$
40 V	1.3 mΩ @ 10 V	207 A
	1.7 mΩ @ 4.5 V	



WDFN9  
CASE 511EB

#### MARKING DIAGRAM

XXXXXX
XXXXXX
AWLYWW
o

XXXX = Specific Device Code  
A = Assembly Location  
WL = Wafer Lot  
Y = Year  
WW = Work Week

#### ORDERING INFORMATION

See detailed ordering and shipping information on page 3 of this data sheet.

# NTTFSSH1D3N04XL

## THERMAL RESISTANCE RATINGS

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case (Bottom)	$R_{\theta JCB}$	1.4	$^{\circ}\text{C}/\text{W}$
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	60	

## ELECTRICAL CHARACTERISTICS ( $T_J = 25^{\circ}\text{C}$ unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
-----------	--------	----------------	-----	-----	-----	------

### OFF CHARACTERISTICS

Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}, I_D = 1\text{ mA}$	40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$\Delta V_{(BR)DSS} / \Delta T_J$	$I_D = 1\text{ mA}$ , Referenced to $25^{\circ}\text{C}$		17		$\text{mV}/^{\circ}\text{C}$
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 40\text{ V}, T_J = 25^{\circ}\text{C}$			10	$\mu\text{A}$
		$V_{DS} = 40\text{ V}, T_J = 125^{\circ}\text{C}$			100	
Gate-to-Source Leakage Current	$I_{GSS}$	$V_{DS} = 0\text{ V}, V_{GS} = 20\text{ V}$			100	nA

### ON CHARACTERISTICS

Drain-to-Source On Resistance	$R_{DS(ON)}$	$V_{GS} = 10\text{ V}, I_D = 24\text{ A}$		1.0	1.3	m $\Omega$
		$V_{GS} = 6\text{ V}, I_D = 24\text{ A}$		1.1	1.4	
		$V_{GS} = 4.5\text{ V}, I_D = 19\text{ A}$		1.4	1.7	
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = 120\ \mu\text{A}$	1.3		2.2	V
Gate Threshold Voltage Temperature Coefficient	$\Delta V_{GS(TH)} / \Delta T_J$	$V_{GS} = V_{DS}, I_D = 120\ \mu\text{A}$		-5		$\text{mV}/^{\circ}\text{C}$
Forward Transconductance	$g_{FS}$	$V_{DS} = 5\text{ V}, I_D = 24\text{ A}$		123		S

### CHARGES, CAPACITANCES & GATE RESISTANCE

Input Capacitance	$C_{ISS}$	$V_{GS} = 0\text{ V}, V_{DS} = 20\text{ V}, f = 1\text{ MHz}$		3480		pF
Output Capacitance	$C_{OSS}$			920		
Reverse Transfer Capacitance	$C_{RSS}$			32		
Output Charge	$Q_{OSS}$			35		
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS} = 4.5\text{ V}, V_{DD} = 20\text{ V}; I_D = 24\text{ A}$		21		
		$V_{GS} = 6\text{ V}, V_{DD} = 20\text{ V}; I_D = 24\text{ A}$		28		
Threshold Gate Charge	$Q_{G(TH)}$	$V_{GS} = 10\text{ V}, V_{DD} = 20\text{ V}; I_D = 24\text{ A}$		47		
Gate-to-Source Charge	$Q_{GS}$			5.7		
Gate-to-Drain Charge	$Q_{GD}$			10		
Gate Plateau Voltage	$V_{GP}$			3.4		
Gate Resistance	$R_G$		$f = 1\text{ MHz}$		2.9	V
				0.6	$\Omega$	

### SWITCHING CHARACTERISTICS

Turn-On Delay Time	$t_{d(ON)}$	Resistive Load, $V_{GS} = 0/10\text{ V}, V_{DD} = 20\text{ V},$ $I_D = 24\text{ A}, R_G = 2.5\ \Omega$		18		ns
Rise Time	$t_r$			5		
Turn-Off Delay Time	$t_{d(OFF)}$			43		
Fall Time	$t_f$			4		

### SOURCE-TO-DRAIN DIODE CHARACTERISTICS

Forward Diode Voltage	$V_{SD}$	$V_{GS} = 0\text{ V}, I_S = 24\text{ A}, T_J = 25^{\circ}\text{C}$		0.79	1.2	V
		$V_{GS} = 0\text{ V}, I_S = 24\text{ A}, T_J = 125^{\circ}\text{C}$		0.65		

# NTTFSSH1D3N04XL

## ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
<b>SOURCE-TO-DRAIN DIODE CHARACTERISTICS</b>						
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 24 A, dI/dt = 1000 A/μs, V <sub>DD</sub> = 20 V		17		ns
Charge Time	t <sub>a</sub>			10		
Discharge Time	t <sub>b</sub>			7		
Reverse Recovery Charge	Q <sub>RR</sub>			84		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

## ORDERING INFORMATION

Device	Marking	Package	Shipping <sup>†</sup>
NTTFSSH1D3N04XL	1D3N04	WDFN9 (Pb-Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# NTTFSSH1D3N04XL

## TYPICAL CHARACTERISTICS

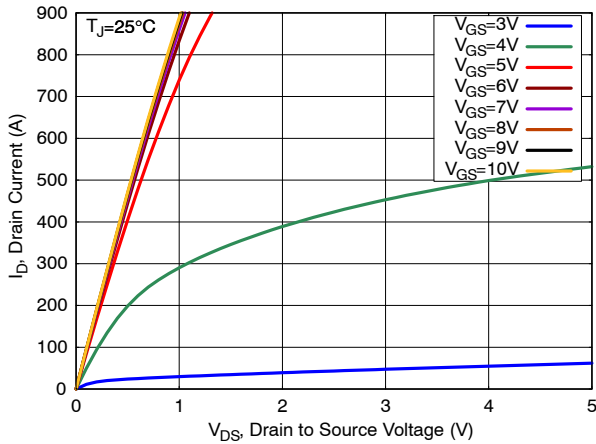


Figure 1. On-Region Characteristics

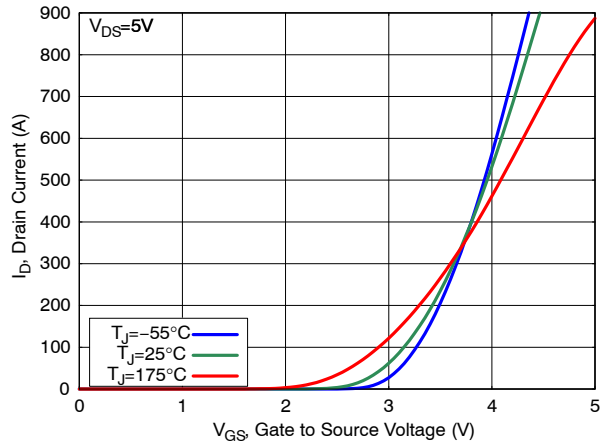


Figure 2. Transfer Characteristics

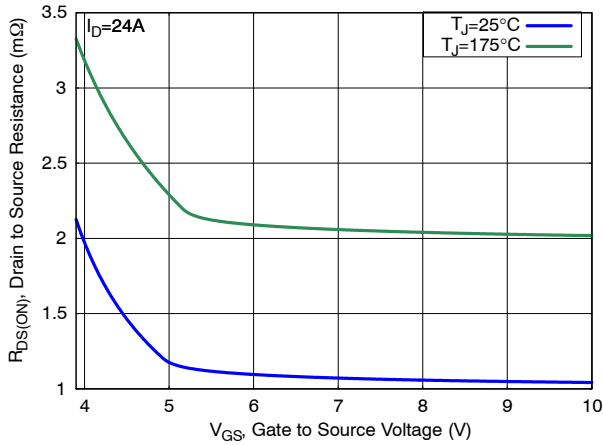


Figure 3. On-Resistance vs. Gate Voltage

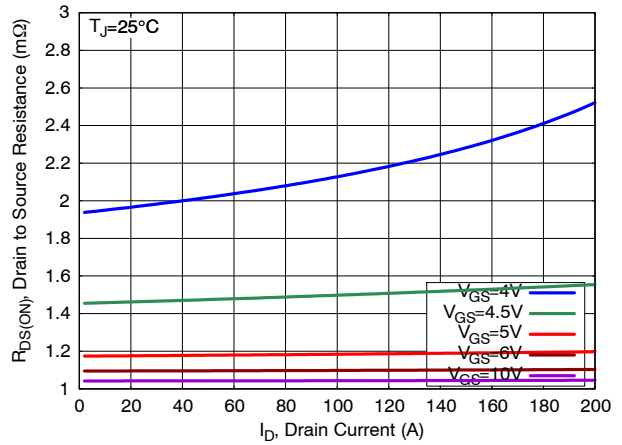


Figure 4. On-Resistance vs. Drain Current

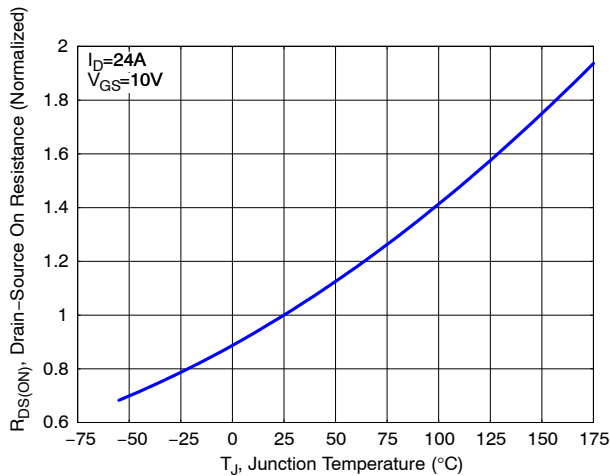


Figure 5. Normalized ON Resistance vs. Junction Temperature

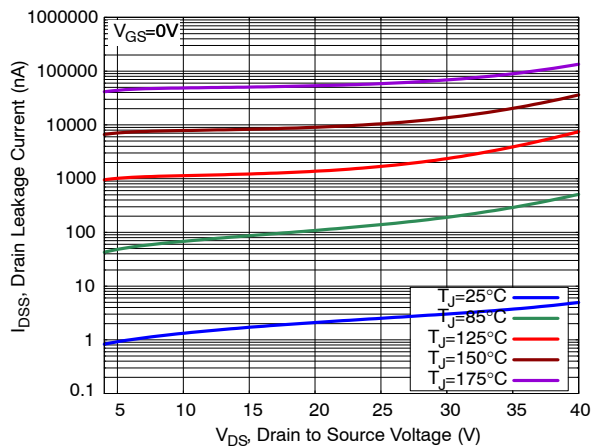


Figure 6. Drain Leakage Current vs. Drain Voltage

# NTTFSSH1D3N04XL

## TYPICAL CHARACTERISTICS

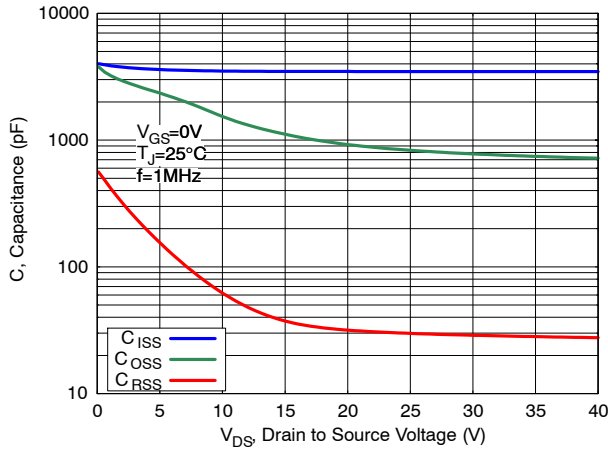


Figure 7. Capacitance Characteristics

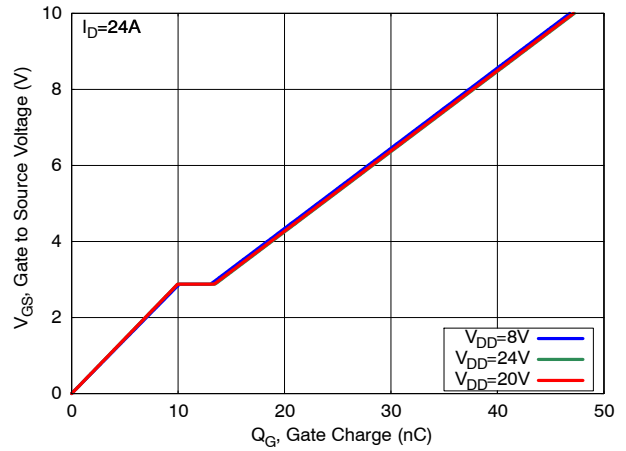


Figure 8. Gate Charge Characteristics

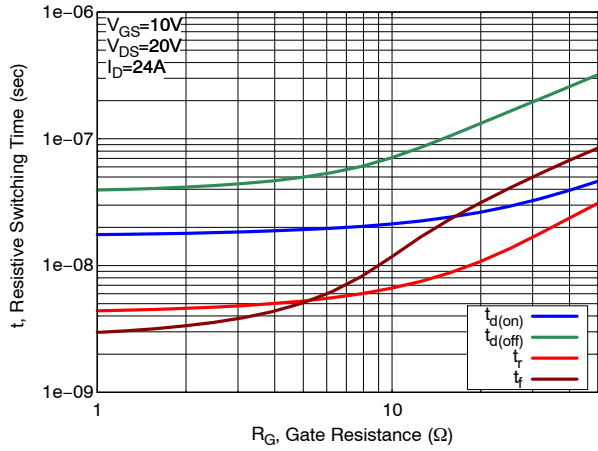


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

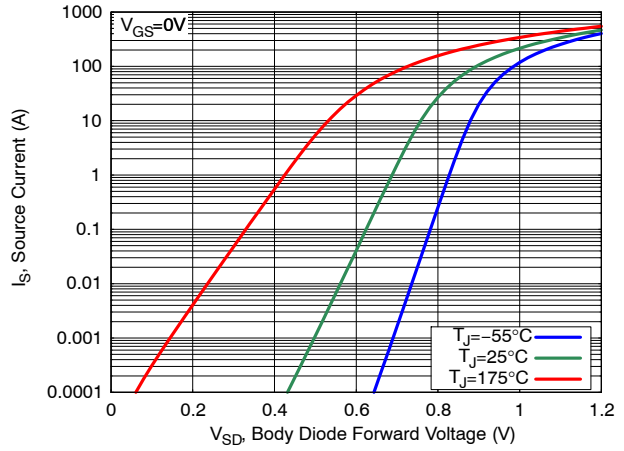


Figure 10. Diode Forward Characteristics

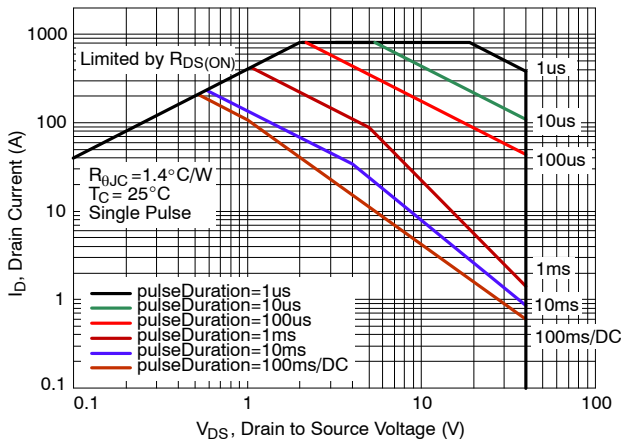


Figure 11. Safe Operating Area (SOA)

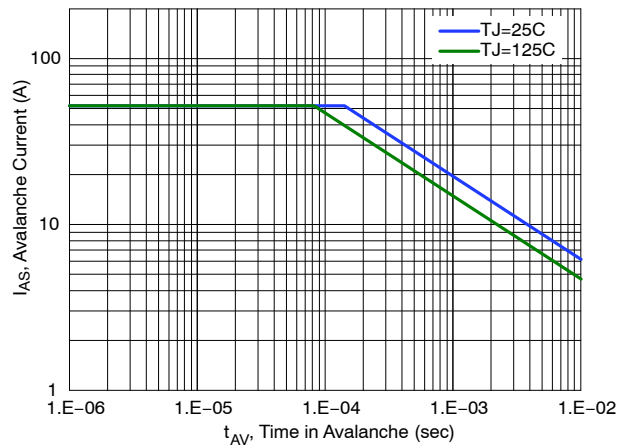
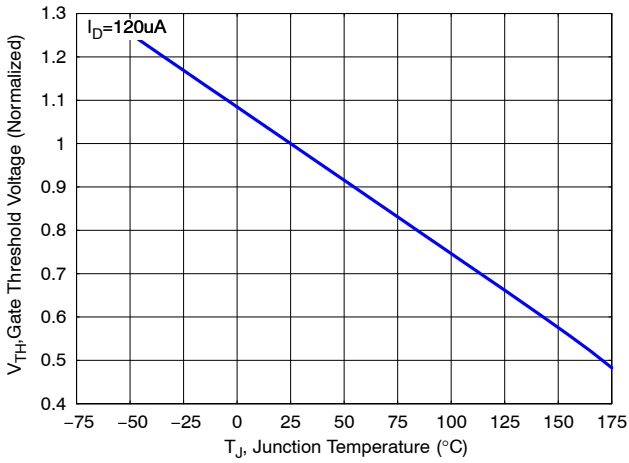


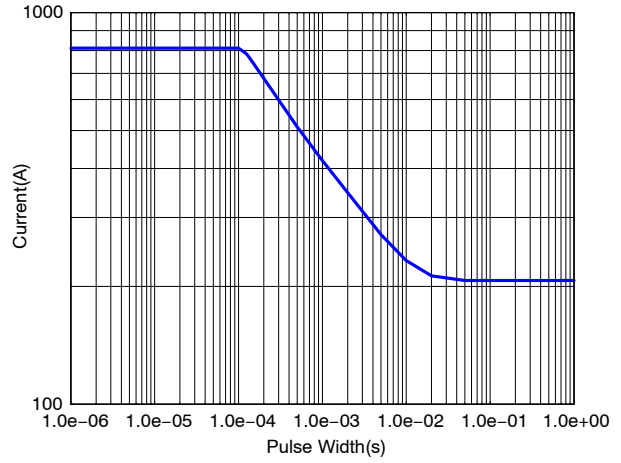
Figure 12. Avalanche Current vs. Pulse Time (UIS)

# NTTFSSH1D3N04XL

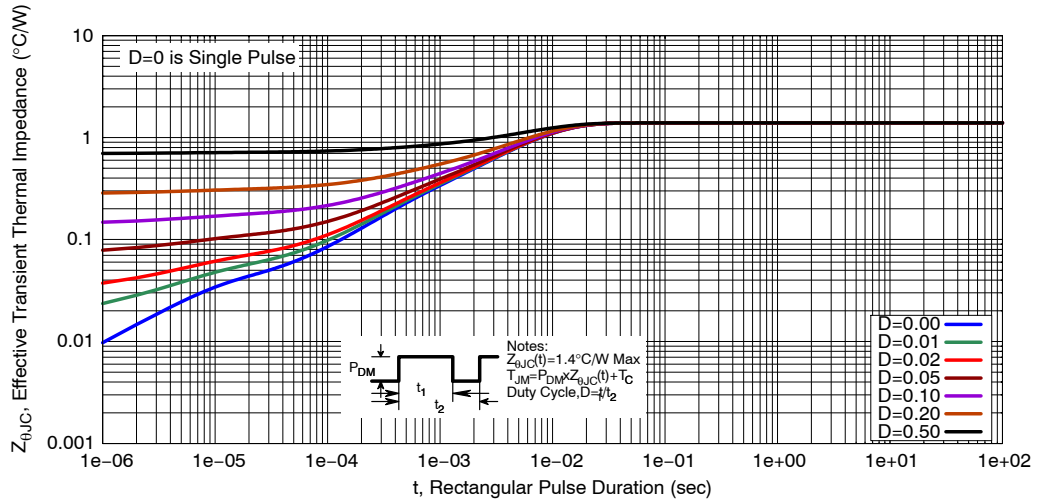
## TYPICAL CHARACTERISTICS



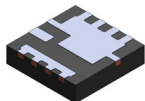
**Figure 13. Gate Threshold Voltage vs. Junction Temperature**



**Figure 14. IDM vs. Pulse Width**

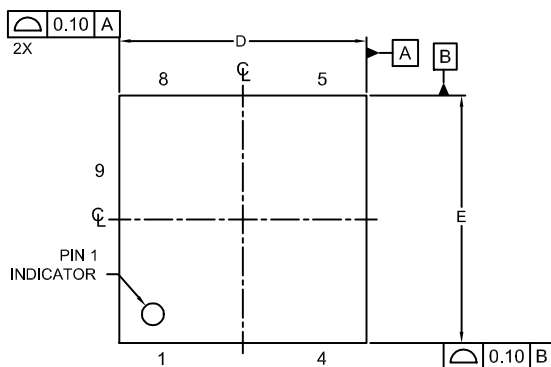


**Figure 15. Transient Thermal Response**

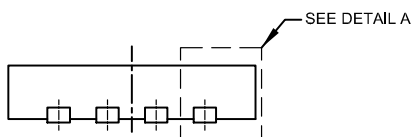


**WDFN9 3.3x3.3, 0.65P**  
**CASE 511EB**  
**ISSUE B**

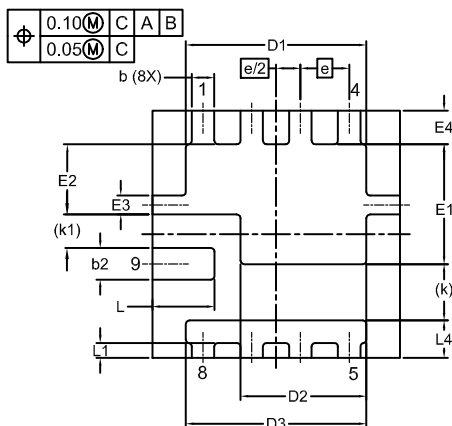
DATE 21 JUL 2021



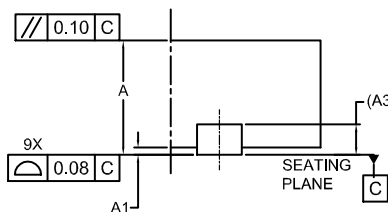
TOP VIEW



FRONT VIEW

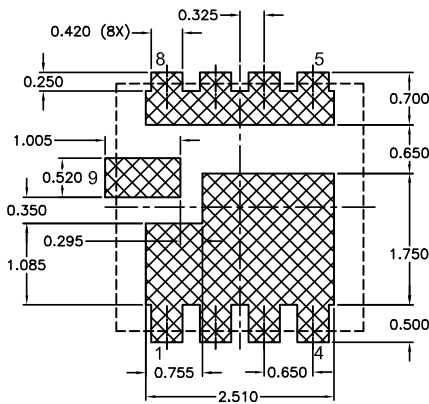


BOTTOM VIEW



DETAIL A

SCALE: 2:1



LAND PATTERN RECOMMENDATION

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

NOTES:

1. CONTROLLING DIMENSION: MILLIMETERS
2. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
3. DIMENSIONS D1, D2, E1 AND E2 DO NOT INCLUDE MOLD FLASH.
4. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT OF THE PACKAGE BODY.

UNIT IN MILLIMETER			
DIM	MIN	NOM	MAX
A	0.70	0.75	0.80
A1	0.00	0.02	0.05
A3	0.20 REF		
b	0.25	0.30	0.35
b2	0.37	0.42	0.47
D	3.20	3.30	3.40
D1	2.31	2.41	2.51
D2	1.58	1.68	1.78
D3	2.31	2.41	2.51
E	3.20	3.30	3.40
E1	1.50	1.60	1.70
E2	0.84	0.94	1.04
E3	0.20	0.25	0.30
E4	0.35	0.45	0.55
e	0.650 BSC		
e/2	0.325 BSC		
k	0.75 REF		
k1	0.45 REF		
L	0.73	0.83	0.93
L1	0.10	0.20	0.30
L4	0.40	0.50	0.60

**GENERIC MARKING DIAGRAM\***



XXXX = Specific Device Code  
 A = Assembly Location  
 WL = Wafer Lot  
 Y = Year  
 WW = Work Week

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "μ", may or may not be present. Some products may not follow the Generic Marking.

<b>DOCUMENT NUMBER:</b>	<b>98AON08290H</b>	Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.
<b>DESCRIPTION:</b>	<b>WDFN9 3.3x3.3, 0.65P</b>	<b>PAGE 1 OF 1</b>

onsemi and ONSEMI are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make changes without further notice to any products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.

**onsemi**, **Onsemi**, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "**onsemi**" or its affiliates and/or subsidiaries in the United States and/or other countries. **onsemi** owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of **onsemi**'s product/patent coverage may be accessed at [www.onsemi.com/site/pdf/Patent-Marking.pdf](http://www.onsemi.com/site/pdf/Patent-Marking.pdf). **onsemi** reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and **onsemi** makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does **onsemi** assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using **onsemi** products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by **onsemi**. "Typical" parameters which may be provided in **onsemi** data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. **onsemi** does not convey any license under any of its intellectual property rights nor the rights of others. **onsemi** products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use **onsemi** products for any such unintended or unauthorized application, Buyer shall indemnify and hold **onsemi** and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that **onsemi** was negligent regarding the design or manufacture of the part. **onsemi** is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

## ADDITIONAL INFORMATION

### TECHNICAL PUBLICATIONS:

Technical Library: [www.onsemi.com/design/resources/technical-documentation](http://www.onsemi.com/design/resources/technical-documentation)  
onsemi Website: [www.onsemi.com](http://www.onsemi.com)

### ONLINE SUPPORT: [www.onsemi.com/support](http://www.onsemi.com/support)

For additional information, please contact your local Sales Representative at [www.onsemi.com/support/sales](http://www.onsemi.com/support/sales)